

### **AUTOMOTIVE GRADE**

# **AUIRFZ44VZS**

HEXFET® Power MOSFET

### **Features**

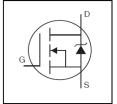
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching

Description

Repetitive Avalanche Allowed up to Timax

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety

- · Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	60V
R <sub>DS(on)</sub> typ.	9.6mΩ
max.	12mΩ
I <sub>D</sub>	57A



G	D	S
Gate	Drain	Source

of other applications			1	
Bass nort number	Dookogo Typo	Standard Pack		Orderable Dort Number
Base part number	Package Type	Form	Quantity	Orderable Part Number

Page part number	Dookogo Typo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
ALUDE744\/70	D <sup>2</sup> Dok	Tube	50	AUIRFZ44VZS
AUIRFZ44VZS	D²-Pak	Tape and Reel Left	800	AUIRFZ44VZSTRL

# **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	57	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	40	Α
I <sub>DM</sub>	Pulsed Drain Current ①	230	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	92	W
	Linear Derating Factor	0.61	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS (Thermally Limited)</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	73	m l
E <sub>AS (Tested)</sub>	Single Pulse Avalanche Energy (Tested Limited) ©	110	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 12a, 12b, 15, 16	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ®		mJ
T <sub>J</sub>	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

# **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.64	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D² Pak ⑦		40	C/VV

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<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.061		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		9.6	12	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 34A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Trans conductance	25			S	$V_{DS} = 25V, I_{D} = 34A$
	Projecto Course Lookens Current			20		$V_{DS} = 60V, V_{GS} = 0V$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	- A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

		_ •			
$Q_g$	Total Gate Charge	 43	65		$I_D = 34A$
$Q_gs$	Gate-to-Source Charge	 11		nC	$V_{DS} = 48V$
$Q_{gd}$	Gate-to-Drain Charge	 18			V <sub>GS</sub> = 10V ③
$t_{d(on)}$	Turn-On Delay Time	 14			$V_{DD} = 30V$
t <sub>r</sub>	Rise Time	 62		20	$I_D = 34A$
$t_{d(off)}$	Turn-Off Delay Time	 35		ns	$R_G = 12\Omega$
t <sub>f</sub>	Fall Time	 38			V <sub>GS</sub> = 10V ③
$L_D$	Internal Drain Inductance	 4.5		nН	Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5		Ш	from package and center of die contact
$C_{iss}$	Input Capacitance	 1690			$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	 270			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance	 130		_	f = 1.0MHz
Coss	Output Capacitance	 1870		pF	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance	 260			$V_{GS} = 0V, V_{DS} = 48V, f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 510			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V$

# **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			57		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			230		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 34A, V_{GS} = 0V$ 3
t <sub>rr</sub>	Reverse Recovery Time		23	35	ns	$T_J = 25^{\circ}C$ , $I_F = 34A$ , $V_{DD} = 30V$
$Q_{rr}$	Reverse Recovery Charge		17	26	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )			

## Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- $\odot$  Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.12mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 34A,  $V_{GS}$  =10V. Part not recommended for use above this value.
- $\oplus$  C<sub>oss eff.</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production, starting  $T_J = 25$ °C, L = 0.12mH,  $R_G = 25\Omega$ ,  $I_{AS} = 34$ A,  $V_{GS} = 10$ V.
- This is applied to D<sup>2</sup>Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994..



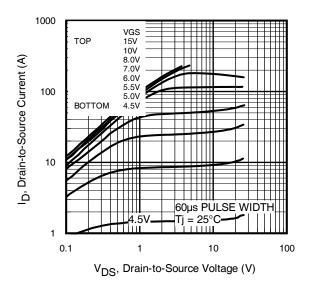


Fig. 1 Typical Output Characteristics

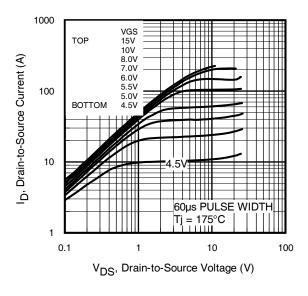


Fig. 2 Typical Output Characteristics

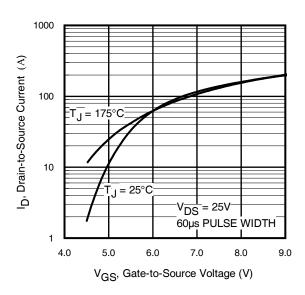


Fig. 3 Typical Transfer Characteristics

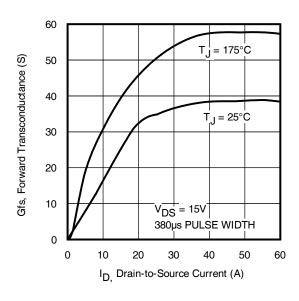


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



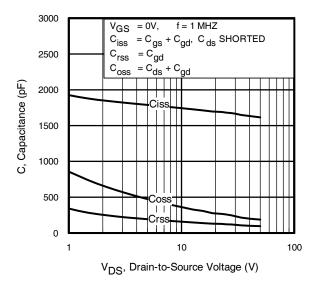


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

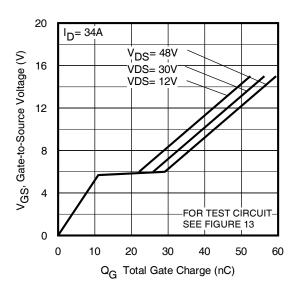
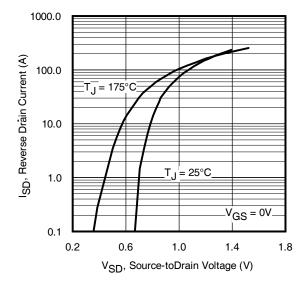


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



**Fig. 7** Typical Source-to-Drain Diode Forward Voltage

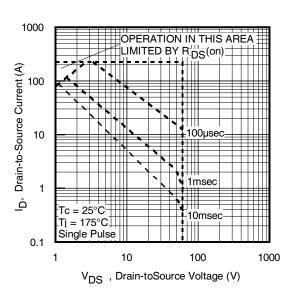
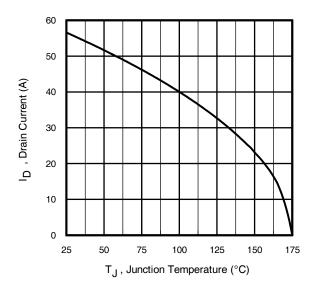
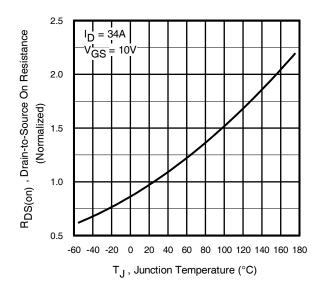


Fig 8. Maximum Safe Operating Area





**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10.** Normalized On-Resistance Vs. Temperature

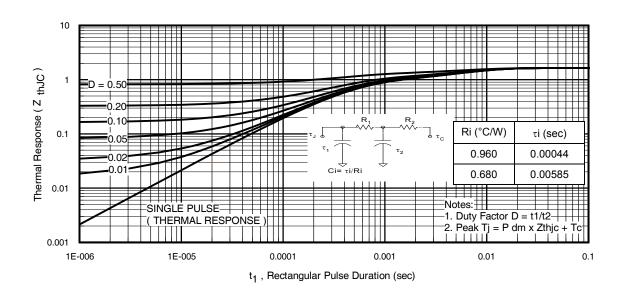


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



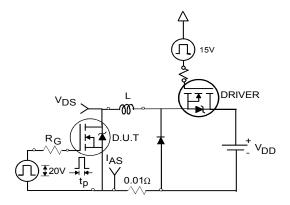


Fig 12a. Unclamped Inductive Test Circuit

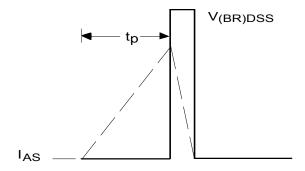


Fig 12b. Unclamped Inductive Waveforms

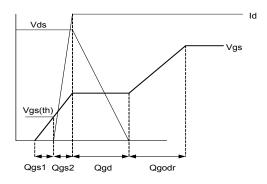


Fig 13a. Gate Charge Waveform

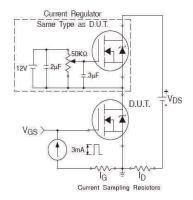


Fig 13b. Gate Charge Test Circuit

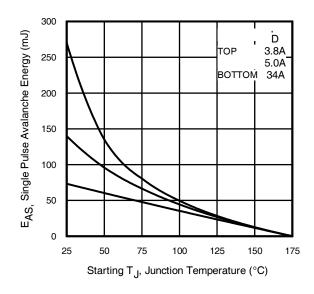


Fig 12c. Maximum Avalanche Energy vs. Drain Current

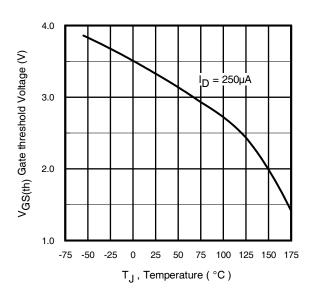


Fig 14. Threshold Voltage Vs. Temperature



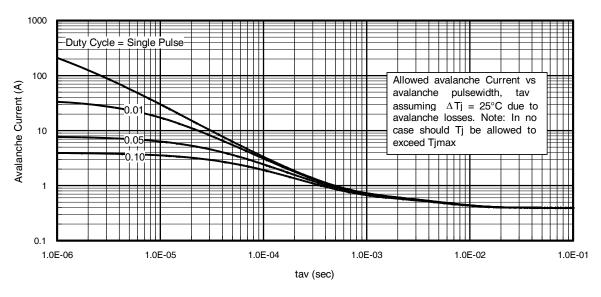
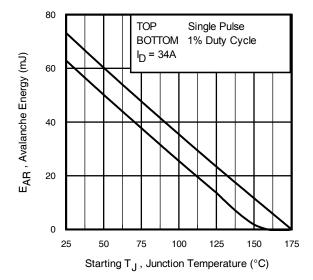


Fig 15. Typical Avalanche Current Vs. Pulse width



# Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 14, 15).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche = tav ·f
  - ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T/ \; Z_{thJC} \\ I_{av} &= 2\Delta T/ \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

Fig 16. Maximum Avalanche Energy vs. Temperature

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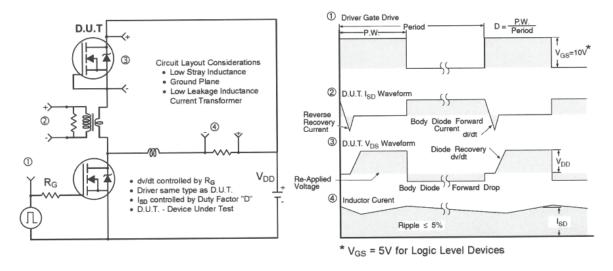


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

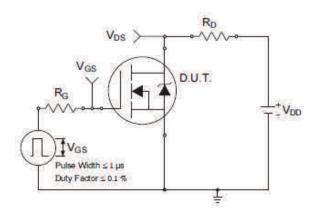


Fig 18a. Switching Time Test Circuit

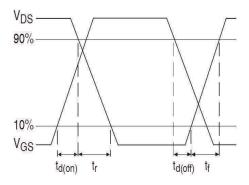
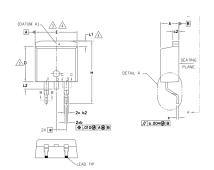
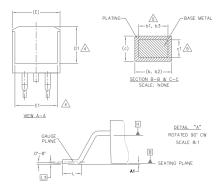


Fig 18b. Switching Time Waveforms



# D<sup>2</sup>-Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S	DIMENSIONS					
M B	MILLIM	ETERS	INC	HES	O T E S	
O L	MIN.	MAX.	MIN.	MAX.	S	
А	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
Ь	0.51	0.99	.020	.039		
Ь1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
ь3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
с1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	_	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245	_	4	
е	2.54	BSC	.100	BSC		
Н	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	_	1.68	_	.066	4	
L2	_	1.78	_	.070		
L3	0.25	BSC	.010	BSC		

#### LEAD ASSIGNMENTS

#### DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

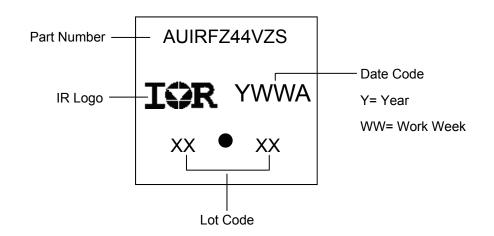
## HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

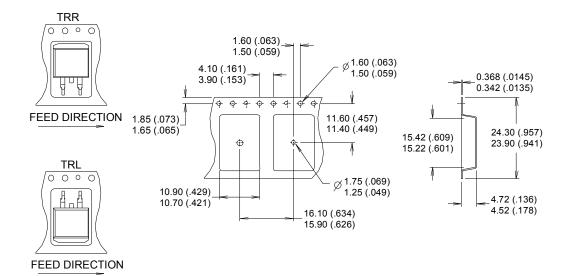
# D<sup>2</sup>-Pak (TO-263AB) Part Marking Information

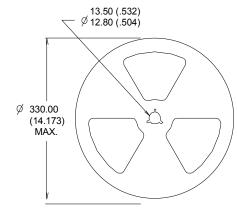


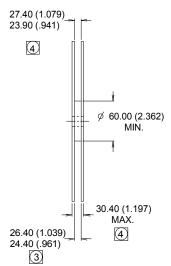
2017-10-13



# D<sup>2</sup>-Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







## NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.



## Qualification Information

		Automotive (per AEC-Q101)				
Qualificat		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the highe Automotive level.				
Moisture	Sensitivity Level	D <sup>2</sup> -Pak	MSL1			
	Machine Madel		Class M4 (+/- 425V) <sup>†</sup>			
	Machine Model	AEC-Q101-002				
ECD	Human Dady Madal	Class H1B (+/- 1000V) <sup>†</sup>				
ESD	Human Body Model	AEC-Q101-001				
	Charged Device Model	Class C5 (+/- 1125V) <sup>†</sup>				
	Charged Device Model	AEC-Q101-005				
RoHS Compliant Yes		Yes				

<sup>†</sup> Highest passing voltage.

# **Revision History**

Date	Comments
10/27/2015	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> </ul>
10/13/2017	Corrected typo error on part marking on page 9.

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